



Exploring material chemistry for direct ink writing of reactively formed conductors†

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Shane Q. Arlington,^{ib}*^{ab} Shashank Vummidi Lakshman,^a Sara C. Barron,^c Jeffery B. DeLisio,^c Juan C. Rodriguez,^c Sharada Narayanan,^a Gregory M. Fritz^c and Timothy P. Weihs*^{ab}

In recent years, there has been a precipitous rise of additive manufacturing (3D printing) as a means of rapid prototyping as well as quickly and cost-effectively fabricating parts or entire systems in small quantities. One limiting factor has been the ability to seamlessly incorporate electrical components into 3D printed systems. While implementation of pick-and-place methods to insert components has readily been achieved, the connections between these components as they are embedded in systems during a build has been limited by the number of suitable inks. Silver inks have been most widely used, but are unsuitable for applications with moderate to high current density as they are susceptible to electromigration induced failure. Here we present a new material concept for 3D printing of electrical conductors: particles with stored chemical energy which, when provided some input energy, undergo a self-propagating high-temperature synthesis (SHS) reaction to form a mechanically and thermally stable, electrically conductive product. Inks incorporating these particles are non-conductive as-printed, but can be converted on demand into a conductive state. In this work, we explore and characterize model chemistries for this approach using physical vapor deposition of multilayer foils and particles and demonstrate a proof of concept of on demand conductor formation.

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1 Introduction

Additive manufacturing (3D printing), the process of building a part by the sequential addition of layers of material, has been in use since the late 1980s.¹ During the 1990s and early 2000s, the high cost of 3D printers limited their use to industrial settings. However, the development of low-cost additive manufacturing tools has both provided direct access to communal additive manufacturing resources, such as at libraries, universities or through web services, and allowed people to purchase their own tools.^{2,3} While this results in inexpensive rapid prototyping being available to more people than ever before, there remains a paucity of solutions to accommodate the inclusion of electronic components within a 3D printed part. For many businesses and individuals, it would advantageous to be able to print stable electrical connections into their parts to allow for quick and

durable connections to both custom and commercial electrical components.

The most robust existing technologies for 3D printed electrical interconnects rely on nanoscale silver particles.^{4–6} For low-current applications, the inks developed using these particles provide a reasonable solution: they sinter at low temperature to form conductive lines and can be made conformal to a substrate, can span gaps, and can even form free-standing structures.⁷ However, while silver has low electrical resistivity, it is also highly susceptible to electromigration, the diffusive movement of a conductive material under an applied current.^{8–10} As such, printed silver interconnects are not suitable in situations which require moderate or high current densities, particularly if a long lifetime is necessary.¹⁰ This leaves an unfilled niche in the additive manufacturing market for printed electromigration-resistant conductors.

In their patent,¹¹ several of the co-authors taught a new design for materials to meet this need, which we call a Reaction Assisted Ink for Longevity (RAIL). The key concept of the approach is that the ink particles in their as-printed state consist of different phases than the ultimate product. Moreover, the RAIL ink is non-conductive in the as-printed state and can be converted into a conductive state on demand, making it innately suitable to applications where an irreversible switching behavior is desirable, such as antifuses. RAIL materials are composed of

^a Department of Materials Science and Engineering, Johns Hopkins University, Baltimore, MD, USA. E-mail: arlington@jhu.edu, weihs@jhu.edu

^b Hopkins Extreme Materials Institute, Johns Hopkins University, Baltimore, MD, USA

^c Microsystems & Advanced Materials Division, The Charles Stark Draper Laboratory, Inc., Cambridge, MA, USA

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Table 1 Reactive systems considered for RAIL applications, comparing heats of reaction ΔH_R , electrical resistivities, coefficients of thermal expansion (CTE), possible aluminum containing MAX phases, prior evidence of SHS formation of MAX phases, and the numbers of moles of aluminum melted per mole of silicide or carbide formed. For the calculation of moles of aluminum melted, we consider both heating the material from room temperature to the melting temperature of aluminum and the enthalpy of fusion of aluminum

Constituents	ΔH_R (J g ⁻¹)	Resistivity ($\mu\Omega$ cm)	CTE (ppm K ⁻¹)	Al MAX phases	Al melted (mol/mol)
Hf + C	1318 ²⁶	37 ²⁷	6.6 ²⁸		8.8
Nb + C	1343 ²⁶	33 ²⁷	6.7 ²⁹	Nb ₂ AlC, Nb ₄ AlC ₃ ³⁰	4.9
Ta + C	749 ²⁶	< 30 ³¹	6.3 ²⁹	Ta ₃ AlC ₂ , Ta ₄ AlC ₃ ³⁰	5.0
Ti + C	3079 ²⁶	68 ³²	7.0 ²⁹	Ti ₂ AlC, Ti ₃ AlC ₂ ^{30*}	6.4
V + C	1602 ²⁶	25–30 ³³	7.3 ³⁴	V ₂ AlC, V ₃ AlC ₂ ³⁰	3.5
Zr + C	1904 ²⁶	48–200 ^{27,35}	6.7 ²⁹	Zr ₂ AlC, Zr ₃ AlC ₂ ^{30,36}	6.8
Zr + 2Si	1080 ²⁶	35–40 ³⁷	8.6 ³⁷		5.6
V + 2Si	2929 ²⁶	50–55 ³⁷	11.2 ³⁷		10.9
Ti + 2Si	1289 ²⁶	13–16 ³⁷	10.5 ³⁷		4.6
Nb + 2Si	841 ²⁶	50 ³⁷	8.4 ³⁷		4.4
Ta + 2Si	502 ²⁶	35–55 ³⁷	8.8 ³⁷		4.2

* Known to form MAX phases in SHS reactions.³⁸

melting temperature of 605 °C and a resistivity of 106 $\mu\Omega$ cm. Given the higher price of these alloys, their higher bulk electrical resistivity, and the relatively similar melting temperatures, we chose commercially pure aluminum as a reflow material for this work. Similarly, while copper is another element with excellent electrical properties, its melting temperature is significantly higher at 1085 °C and therefore it was not selected.

Second, we identified groups of elements which can generate heat and provide a low resistivity product. Many of the materials commonly studied for SHS, such as Al/Ni, result in intermetallic phases with resistivities ranging from 10–60 $\mu\Omega$ cm.^{39,40} However, many of these reactions either already include aluminum or will react with aluminum, thereby forming a single high temperature intermetallic without melting and reflowing. Since these intermetallic phases have higher resistivity than Al and are generally brittle, a system capable of producing Al as a product is preferable. Compared to the aluminide reactions, carbide and silicide formation reactions can be even more energetic, have products with similar or lower resistivities, and are less likely to interact with Al.³⁹ These properties allow for a low-resistivity carbide phase locked into and supported by a reflowed Al matrix. By employing a carbide formation reaction, the possibilities of reaction with aluminum are not completely bypassed; many of the carbide forming systems can form ternary compounds, including structured ternary MAX phases.⁴¹ MAX phases have extremely low electrical resistivities and are resistant to thermal shock, but are still brittle at room temperature.⁴² As such, they may negatively affect the mechanical properties of printed conductive lines. Further, as with Al-containing intermetallics, MAX phases reduce the ability of Al to act as a reflow material for the printed line. Table 1 summarizes a number of carbide and silicide formation pairs, including their heats of reaction, product resistivities, product coefficients of thermal expansion (CTE), and any known MAX phases formed with Al. To provide a more meaningful comparison than the heat of reaction, we also include an estimate of the number of moles of Al which can be melted and reflowed by the heat released in forming a mole of

the product, assuming no heat losses. This value is calculated by dividing the heat of reaction by an enthalpy value which accounts for heating Al from room temperature to its melting temperature of 660 °C, as well as the latent heat of melting. Given that in any use there will be heat losses, these values are provided as useful points of comparison between the various reaction pairs and are not meant as realistic expectations.

Final selection from the systems shown in Table 1 was a balance of several factors, such as minimizing CTE and resistivity, maximizing the Al which could be reflowed, and selecting elements with hardnesses suitable to produce finely-spaced layering in ball milled powders. At first, Hf/C seemed to be the clear winner. However, since scaled production would rely on ball milling, the extreme pyrophoricity of Hf necessitated an alternate selection. Most of the silicides have significantly higher CTEs than the carbides, although they may still prove interesting to investigate at a later date. Of the carbide systems, Ti/C, V/C, and Zr/C have comparable properties, but the known SHS formation of brittle MAX phases in the Al/Ti/C system may have provided additional complications. Given that V is very hard, it poses challenges to scaled production *via* ball milling. Therefore, we selected Al/Zr/C as the ternary system to investigate the RAIL concept. In this work we explore the effects of chemistry in the Al/Zr/C system using the highly controlled composition and structure provided by PVD materials.

Three Al/Zr/C sample compositions are presented here: a low Al content film with overall composition of Al:Zr:C 2:1.2:1; a medium Al content film with overall composition of Al:Zr:C 3:1.2:1; and a high Al content film with overall composition of Al:Zr:C 4.4:1:1. Based on observations that high-Al content films formed predominantly Al–Zr intermetallics, the low and medium-Al content films were made with a higher Zr:C ratio of 1.2:1 to assist in the reactions between Al/Zr while maintaining sufficient Zr to react with C. This is of particular importance given that ZrC is not a stoichiometric compound and the phase formed is often rich in Zr. The resulting properties of the foils employed in this study are summarized in Table 2.



Table 2 Summary of multilayer foils fabricated and tested in this study

Chemistry Al:Zr:C	Thickness (μm)	Layer thicknesses (nm)			Short name
		Al	Zr	C	
2:1.2:1	12	87	73	23	2Al
3:1.2:1	12	137	77	24	3Al
4.4:1:1	12	73	23	9	4.4Al

2 Experimental

2.1 Sample fabrication

Physical vapor deposited (PVD) foils and particles were fabricated by DC magnetron sputtering from $12'' \times 5''$ linear targets spaced around an octagonal rotating substrate carousel. Multilayers were built up by rotating the substrates past each target in series. To assist in the carbide formation in the lower Al-content films, two C targets were used simultaneously to increase the layer-thickness of C due to its low sputter rate. Resulting film properties are summarized in Table 2.

The targets used were C [99.999 wt% pure], commercially pure Al [Al 1100: 99 wt% Al, 0.87 wt% (Si,Fe), 0.12 wt% Cu], and Zr [99.7 wt% pure]. Deposition occurred at 1.7 mTorr of 99.999% pure Ar in a vacuum chamber, where the base pressure was better than 3×10^{-6} Torr. The substrate carousel was water-cooled to maintain near-ambient deposition temperatures. The substrates used were brass plates, which were affixed firmly to the carousel by screws. The substrates were patterned with tape to create rectangular film sections, which were removed from the substrate by flexure post-deposition. These freestanding foils were used for the thermal and structural investigations. A small batch of PVD particles of the most promising composition (2Al) were fabricated by sputtering onto polymer mesh substrates. During deposition, the coating is separated by the segments of the mesh, creating particles with a highly-curved, fingernail-like shape (see Fig. 8). These particles were removed from the substrate by flexure under water,⁴³ and used to create a syringe-extrudable ink using dimethylformamide (DMF) as a solvent and cellulose acetate as a binder.

2.2 Thermal analysis, propagation, and ignition

Foil samples were tested in a TA Instruments Q600 simultaneous DTA/TGA, with a purge gas of high purity (99.995%) Ar. All experiments were performed at a heating rate of $20 \text{ }^\circ\text{C min}^{-1}$ up to $1450 \text{ }^\circ\text{C}$. Samples were also quenched in the Q600 at lower temperatures to investigate intermediate phases.

Propagation velocities were measured by reacting free-standing pieces of foil in air using a vertically mounted high-speed visible light camera (NAC Memrecam HX-6) with a 90 mm macro lens (Tamron). The reaction was ignited by an electric spark from a DC power supply (MPJA 1602PS). The reaction front position was tracked using Tracker (<https://physlets.org/tracker/>) and the velocity was found by taking a regression of the reaction front position as a function of time. Two single channel pyrometers (Kleiber KGA740-LO and KG740-LO) with a combined sensitive range of $200\text{--}2500 \text{ }^\circ\text{C}$ were used to measure film temperature during propagation.

The emissivity was assumed to be $\epsilon = 0.1$, based on values for polished Al and prior work with other multilayers.^{44,45} In all cases, the outside layer of the foil was Al.

Ignition temperatures were determined by the hot plate method.^{14,43} A Watlow CER-1-01 hot plate was held at constant temperature, monitored by an internal thermocouple and two surface mounted thermocouples. Foil pieces approximately $2 \text{ mm} \times 2 \text{ mm}$ in size were dropped onto the hot plate surface and observed visually. Those ignited by the hot plate reacted and gave off a burst of light. Fresh samples were used for each experiment. The temperature of the hot plate was increased until the threshold temperature for ignition was found.

To mimic use in additive manufacturing, we ignited foils using Intense Pulsed Light (IPL) in a NovaCentrix PulseForge 1200. This system employs a high power Xenon flash bulb to provide a high energy pulse to a large area simultaneously. The typical settings used were five pulses over 6 ms with a 75% duty cycle, resulting in an energy density of 8.5 J cm^{-2} as measured by the built-in Bolometer. These energy densities are well above the measured threshold values for all compositions, which were determined by systematically lowering the power settings until the foils did not react.

2.3 X-ray diffraction and electron microscopy

X-ray diffraction was employed for phase identification, using a PANalytical X'Pert Pro with Cu K_α radiation ($\lambda_{\text{Cu}} = 0.154 \text{ nm}$) and a symmetric θ - 2θ scan geometry. X-ray microdiffraction was performed on a quenched film using a Bruker D8 with an area detector and a collimated $500 \mu\text{m}$ Co K_α ($\lambda_{\text{Co}} = 0.179 \text{ nm}$) beam. Scanning electron microscopy (SEM) was performed on a TESCAN Mira 3 to characterize the microstructure of samples before and after reaction. Cross-sectional samples were prepared by mounting in epoxy (Epoxy Technology Epotek 301) and mechanical polishing.

2.4 Electrical resistivity

The electrical resistivity of foils, both as-deposited and post-reaction, as well as as-extruded and post-reacted lines of PVD particles were assessed by the standard 4-point probe method using a Signatone 1160 series probe station. Foils were reacted for electrical testing using the IPL system described above.

3 Results

3.1 Rapid heating

Table 3 provides an overview of the ignition temperatures, IPL ignition energy densities, and reaction velocities of foils locally heated by an electric spark. Equivalent ignition temperatures for the IPL energy densities were calculated assuming a broadband absorptivity of $\alpha = 0.37$ and assuming that the input energy uniformly heats the foil through its thickness. Literature values of α for Al (the surface layer) range from 0.1 to 0.5, depending on the method of measurement, sample preparation, oxide thickness, *etc.*^{46,47} Given that all foils were fabricated by the same method in the same chamber, we assume



Table 3 Summary of which foils underwent a sustained self-propagating formation reaction, reaction velocities, ignition temperatures measured by hot-plate, energy densities required for ignition under Intense Pulsed Light (IPL) and calculated IPL ignition temperatures assuming an absorptivity of 0.37. All foils which underwent a sustained self-propagating reaction resulted in final products of primarily ZrC and Al

Sample chemistry	Hot plate ignition temperature (°C)	IPL ignition energy density (J cm^{-2})	IPL equivalent temperature (°C)	Propagation velocity (m s^{-1})
2Al:1.2Zr:C	397	2.30	365	0.68 ± 0.08
3Al:1.2Zr:C	458	3.07	465	0.53 ± 0.03
4.4Al:Zr:C	538	3.85	556	Did not propagate

that they have a similar absorptivity and thus provide these temperatures to show the trend in ignition thresholds for IPL is very similar to that from the hot plate method.

All foils tested with a uniform energy input by IPL or hot plate propagated through the foil thickness. However, when 4.4Al foils were tested using a local ignition source, a self-propagating reaction was not sustained along the length of the foil. All 2Al and 3Al foils reacted by both hot plate and IPL to form ZrC and Al as the predominant product phases. However, 4.4Al foils produced mixtures of Al_3Zr , ZrC, and Al *via* hot plate ignition, and $\text{Al}_3\text{Zr}_3\text{C}_5$, ZrC, and Al under IPL ignition. Fig. 3 shows the final phases determined by X-ray Diffraction (XRD) for foils reacted by the various fast-heating techniques. Some of the breadth to several of the ZrC peaks for 2Al and 3Al foils may be due to a small fraction of the ternary $\text{Al}_3\text{Zr}_3\text{C}_5$.

Fig. 4 shows representative temperature–time curves acquired by pyrometry for electrically ignited 2Al and 3Al foils. After applying an electric spark, both samples exhibit a short incubation period before a relatively constant local heating rate just below $40\,000\text{ °C s}^{-1}$. After passing the melting temperature of Al, the local heating rate increases rapidly to approximately $500\,000\text{ °C s}^{-1}$, comparable to other pyrometry based studies of reactive multilayers.⁴⁴

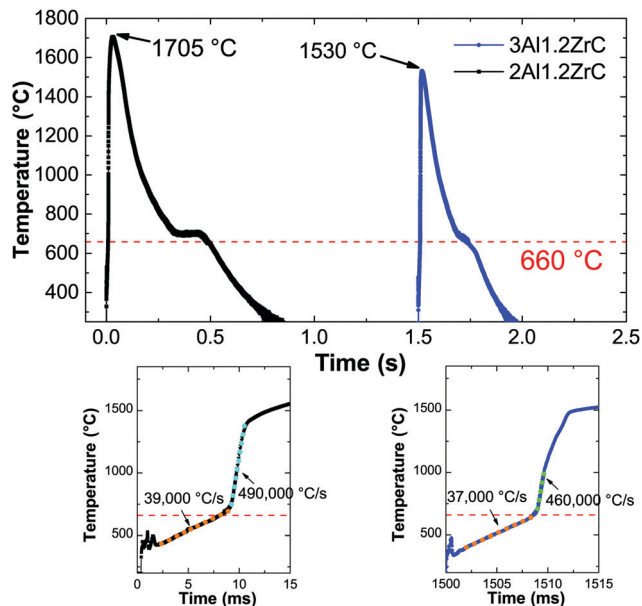


Fig. 4 (top) Temperature vs. time data from pyrometry on 2Al and 3Al thin films ignited by electric spark. (bottom) Expanded data at the start of reaction, demonstrating a rapid increase in heating rate after passing the Al melting temperature. Horizontal offset of 1.5 s applied to the 3Al data for clarity.

Given the lack of a self-propagating reaction in 4.4Al foils under local ignition, we investigated what intermediate phases may exist in the propagating reaction wave by micro-diffraction on a 2Al foil quenched during a self-propagating reaction. As seen in Fig. 5, an intermediate phase of Al_3Zr is present near the quench zone, along with a large fraction of unreacted Al and Zr. Within a few hundred microns, however, the unreacted Zr disappears entirely, replaced by a mixture of predominantly ZrC and Al with some Al_3Zr . In the fully reacted zone, only ZrC and Al are detectable, consistent with all fully reacted 2Al and 3Al foils.

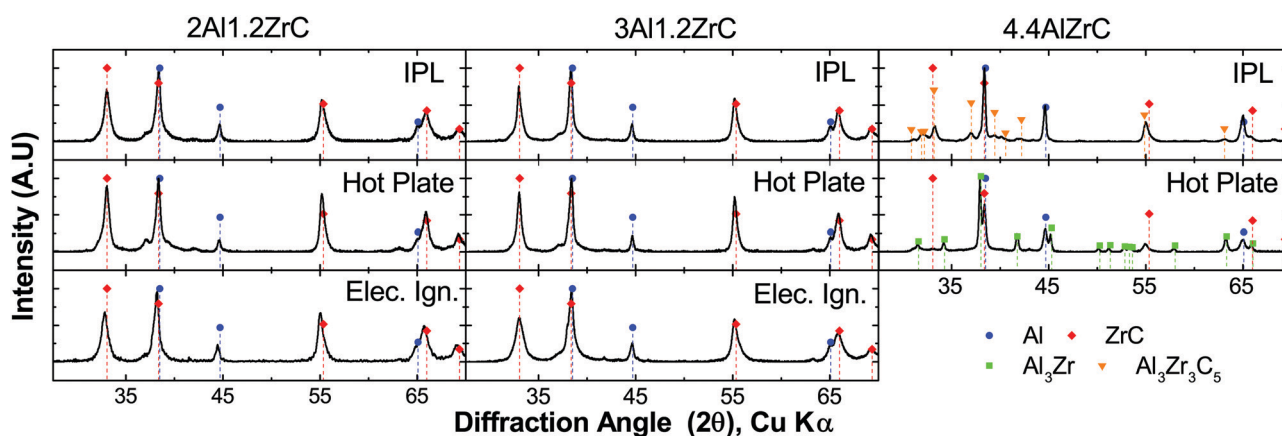


Fig. 3 Comparison of phases formed in 2Al, 3Al and 4.4Al thin films after reactions ignited by IPL, hot plate, and electric spark. Arranged in order of decreasing uniformity of energy delivery to the sample during ignition, demonstrating that for compositions too rich in Al, only very uniform ignition can produce the desired product phases. Note that 4.4Al foils would not propagate from an electric spark.



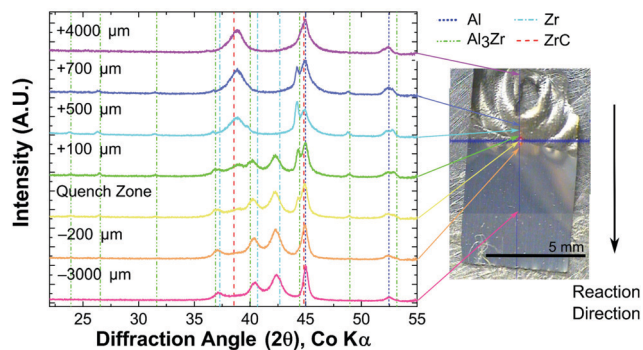


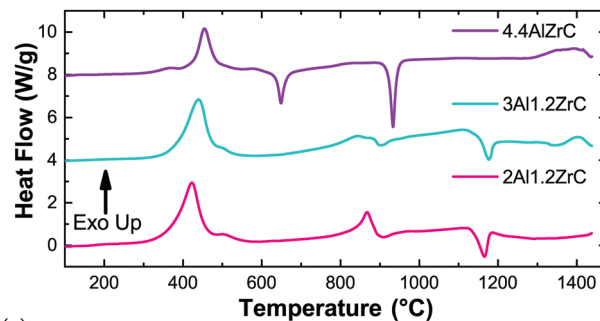
Fig. 5 X-ray micro-diffraction of 2Al film with reaction wave quenched between two pieces of copper. The reaction wave traveled from the top of the foil downward. Locations where each diffraction pattern was acquired indicated on micrograph. In the far-field reacted zone, the observed phases are only ZrC and Al, near the quench zone there is a mixture of Al_3Zr , ZrC, and Al, with the balance moving towards Al_3Zr in the direction of the unreacted zone. The blue line across the micrograph locates the quench zone.

3.2 Slow heating

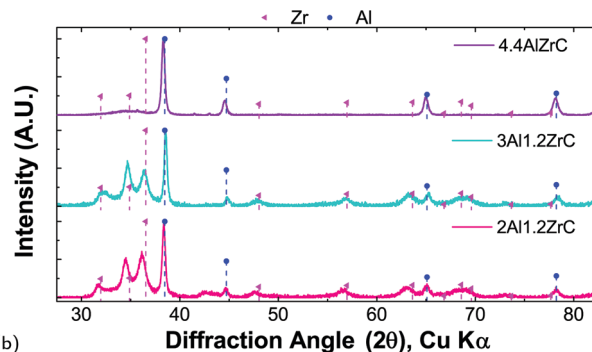
Al/Zr/C foils heated slowly ($0.33\text{ }^\circ\text{C min}^{-1}$) evidence a clear effect of composition on the reaction pathway, as seen in Fig. 6. For all three compositions, there is a main exothermic peak associated with the formation of Al_3Zr . The peak shifts to higher temperature as a function of Al content, with a maximum at $422\text{ }^\circ\text{C}$ for 2Al, $439\text{ }^\circ\text{C}$ for 3Al, and $456\text{ }^\circ\text{C}$ for 4.4Al. For all compositions, there is a shoulder beyond the main exotherm at $500\text{ }^\circ\text{C}$, though its magnitude diminishes with increasing Al content. During the first heating, only the 4.4Al film – which has excess Al after conversion of Zr to Al_3Zr – evidences an Al-melting endotherm. This, along with quenched X-ray data, support that after the first endotherm the predominant phase is Al_3Zr .

There is a second exothermic region for all compositions between $700\text{ }^\circ\text{C}$ and $900\text{ }^\circ\text{C}$. This exotherm terminates in an endotherm which is much more noticeable for 4.4Al, but appears for all three compositions. The exotherm is fairly broad for 3Al and 4.4Al, but has a noticeable peak for 2Al. Quenching the samples at temperatures beyond the endotherm indicate conversion of some of the Al_3Zr to ternary Al–Zr–C phases, such as $\text{Al}_3\text{Zr}_2\text{C}_4$ and $\text{Al}_3\text{Zr}_3\text{C}_5$. For the 2Al and 3Al compositions, there is an additional high temperature endotherm centered at $1170\text{ }^\circ\text{C}$, and all three have some exothermic behavior from $1300\text{ }^\circ\text{C}$ to $1450\text{ }^\circ\text{C}$. As demonstrated by the final phases shown in Fig. 6(c), heating in the DTA yields poor conversion to ZrC, with the bulk of the material still Al_3Zr or an Al–Zr–C ternary phase.

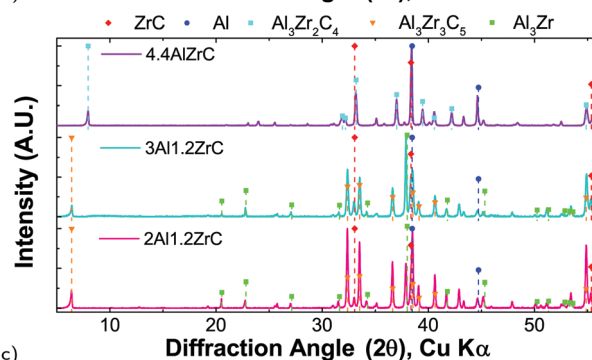
Apart from the Al melting endotherms for 4.4Al, the endotherms are not well attributable to either the ternary phases found in quenched foils or any binary phases. All three compositions have high temperature endotherms which exist in subsequent scans. Therefore there may be other phases which form and subsequently decompose at elevated temperatures and are not detectable after quenching. Similar behavior has been observed in Al–Ti–C with very low C content, where at high temperatures a peritectic reaction drives formation of a titanium carbide phase, an increasing amount of which



(a)



(b)



(c)

Fig. 6 (a) Heat flow versus temperature curves for multilayer foils heated to $1450\text{ }^\circ\text{C}$ in a TA Instruments Q600. Baseline fit to a second run on the post-reacted sample. (b) X-ray diffraction patterns of multilayer foils in their as-deposited state. (c) X-ray diffraction patterns of multilayer foils after heating to $1450\text{ }^\circ\text{C}$.

persisted on cooling after repeated cycles.⁴⁸ Our experiments show minimal changes in peak intensities after several cycles (not shown), but a similar reaction is likely still at play.

3.3 Microstructure

As seen in Fig. 7, during slow heating the layered structure of the as-deposited foil breaks down, and micron-scale cuboidal grains of the binary and ternary intermetallics form. The methods of fast-heating tested have some effect on the eventual microstructure, but none of them evidence micron-sized ZrC product, instead resulting in nanoscale ZrC. For 2Al and 3Al foils, all fast-heating methods induce significant fracturing resulting in internal porosity over multiple lengthscales, as is most evident in Fig. 7(f).

Electrically ignited foils typically form multilayer sheet-like product phases of ZrC and Al under vacuum and in air.



the desired on-demand transition from non-conductive to conductive. The lines had much higher resistivity than bulk foil samples due to poor joining of the particles, likely caused by the very thin molten aluminum regions and poor packing density of the oddly-shaped particles.⁴³ In a forthcoming publication we will demonstrate that printed inks employing ball milled powders of the same composition are likewise non-conductive after printing, but achieve a post-reacted resistivity two orders of magnitude lower than printed PVD particles.¹⁹

4 Discussion

While there is no extant data on Al/Zr/C multilayers, Song *et al.*^{51,52} and Hu *et al.*⁵³ have, respectively, published on SHS reactions and thermal explosion reactions in ball milled Al/Zr/C powders with varying aluminum contents. These allow for some interesting comparisons with our work. Song *et al.* showed that the phases formed can be shifted from Zr/C + Al (below 40 wt% Al) to Al₃Zr + ZrC + Al + Al₃Zr₃C₅ (starting at 40 wt% Al and very pronounced at 50 wt% Al), which they attribute to a decreased adiabatic reaction temperature with increasing Al content. Our 4.4Al films have a mass fraction of over 53 wt% Al, yet when initiated uniformly by IPL form predominantly ZrC and Al as the product phases. However, these films are unable to sustain a self-propagating reaction when ignited locally by an electric spark, and when initiated on a hot plate they similarly result in a mixture of Al₃Zr, ZrC, and Al.

Both Song and Hu claim that the maximum reaction temperature (above 1920 °C) being above the Al₃Zr melting temperature (1580 °C) is crucial for the formation of ZrC.^{52,53} In the thermal traces of an SHS reaction in a pressed pellet of ball milled Al/Zr/C presented by Song *et al.*, there is a clear multi-step reaction over a period of 6 seconds which indicates that some intermediate Al₃Zr melts,⁵² but for the thermal explosions measured by Hu there is no indication of Al₃Zr melting during the reaction process. Likewise, in our pyrometry traces for both 2Al and 3Al foils (Fig. 4), we see no indication of Al₃Zr melting. In the case of the 3Al foils, the maximum temperature does not even exceed the melting point of Al₃Zr. Since the melting of Al precipitates a dramatic increase in the reaction rate (as evidenced by the heating rate),⁴⁴ we posit that the heat released by Al and Zr mixing drives the reaction temperature up, facilitating the direct reaction between Zr and C which eventually consumes the Zr without Zr melting.

This explanation is consistent with the composition near a quench front presented in Fig. 5. Song *et al.* quenched a pressed pellet undergoing SHS and found significantly more Al₃Zr near the quench region than presented here, suggesting that for these films with very fine reactant spacing the reaction can occur with significantly less Al₃Zr formed to drive the ZrC formation.

During slow heating by DTA of their powder compacts, Hu *et al.* were able to form significantly more ZrC than reported here.⁵³ This again can be attributed to the very fine reactant spacing in our thin films, where the Al₃Zr reaction can go to completion in the DTA, whereas the powder compacts have an

incomplete reaction between Zr and Al at lower temperatures (as verified by XRD), allowing for the direct reaction between Zr and C rather than necessitating the breakdown of Al₃Zr or other intermetallic phases at high temperature.

Overall, these differences in both slow and fast heating and the differences in the initial microstructure suggest that for implementing the RAIL concept, the reactant spacing in the ink particles, as well as the thermal history of the printed lines, may have a large influence over their performance in producing the desired phases and therefore their electrical properties. The high temperature endotherms seen during slow heating (Fig. 6) are not well attributed, but are likely due to decomposition reactions of ternary phases present in the systems. The difference in location and shift of these endotherms between compositions is likely due to the different metastable ternary phases they form. We have begun investigations into the heating rate and composition – and thereby composition gradient⁵⁴ – effects on the Al/Zr/C system using nanocalorimetry⁵⁵ *in situ* in a synchrotron^{56,57} to perform X-ray diffraction, which will be the focus of a future publication.

Ultimately, both the 3Al and 2Al films resulted in the desired product phases after self-propagation, and thus the question of intermediate phases is only an issue if an application will induce sufficient heat-sinking to retard the reaction. Since that may frequently be the case, Al-lean compositions with higher adiabatic reaction temperatures will likely be more successful commercially. A quick comparison of the pyrometry data presented in Fig. 4 demonstrates that not only can the lower Al-content material reach higher temperatures, but the time at sufficient temperature for Al to reflow is doubled. As mentioned previously, inks using ball milled Al/Zr/C powders based on the 2Al composition presented here are performing well and will be the focus of another publication. An example of a printed line of ball milled powders after reaction is presented in Fig. 2.

The success of these inks highlights some differences between the stochastic ball milled powders and the well-controlled thin films presented here. Firstly, the films presented here create significant voids when they react *via* SHS. In general, fracture and porosity in reacted thin films occurs due to gaseous products of reaction.^{58,59} While there may be some trapped gas in our foils from fabrication, it is more likely that the fractures occur due to thermal stresses developed by the different CTEs of the ZrC and Al layers during cooling from SHS. Foils quenched during SHS imaged in the SEM (ESI,† Fig. S1) demonstrated that the fracture began near the quench zone where ZrC was beginning to form, and over the course of 200 μm became very severe. This correlates well with the XRD analysis of the dominant phases near a quench front.

Comparable ball milled powders, on the other hand, demonstrate good particle agglomeration, so this issue seems to be intrinsic to the PVD foils and tied directly to the layered product phases and thin Al layers. The fracture and voiding in our films contribute to the relatively poor resistivity measurements presented in Fig. 9. The resistivity of bulk IPL-reacted foils nearly doubles when a junction is introduced, and attempts to create multiple junctions were unsuccessful. A reacted printed line of



PVD particles increased the resistivity by several orders of magnitude. This indicates that the extremely controlled initial microstructure and of PVD materials may be disadvantageous. As we will explore in detail in a separate publication,¹⁹ ball milled materials can be fabricated and easily 3D printed by direct ink writing which, after reaction, have consistent resistivities on the order of 300 $\mu\Omega$ cm.

5 Conclusions

To overcome the limitations of currently available conductive inks, we propose a new paradigm: a reactive ink which is non-conductive in the as-printed state, but when ignited produces its own heat to form a thermally and mechanically stable, electrically conductive product phase. Herein, we explored the design of chemistries for this approach and tested Al/Zr/C as a candidate material system. We assessed how varying the Al content changes the phase formation sequence, linear propagation rate, and ignition threshold for highly microstructurally controlled thin films. We demonstrated that an Al content far below a theoretically predicted threshold retards the SHS reaction in these materials, resulting in undesired product phases. For sufficiently Al-lean compositions, the reaction temperatures during SHS can be lower than the melting point of the expected intermediate (Al_3Zr), while still achieving apparently full conversion to the desired products. By SEM we determined the post-reacted microstructure changes gradually from layered product sheets to a more bicontinuous structure with increasing energy uniformity of the initiating source. In all cases, the foils and PVD particles generated internal voids, which we attribute to thermal stresses between layered product phases. The stochastic microstructure of ball milled powders appears to obviate this effect and provides for better agglomeration. We measured the electrical resistivity of foils and syringe-extruded lines of a PVD particle ink before and after reaction. Using that PVD particle ink, we demonstrated the on-demand switch from a non-conductive to a conductive state despite the limitations of the PVD particles. We posit that for actual applications, relatively Al-lean compositions – such as the 2:1.2:1 Al:Zr:C composition presented here – are more likely to be successful due to their higher adiabatic temperature and the longer time available for Al to reflow, both of which will aid in forming the desired product phases and microstructure when dealing with heat losses from the ink binder and substrate.

Conflicts of interest

GMF and SCB are inventors on US Patents 10308828 and 10240058 which relate to applications of the materials discussed herein for 3D printing electrical conductors.

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Notes and references

- 1 J.-P. Kruth, M. Leu and T. Nakagawa, *CIRP Ann.*, 1998, **47**, 525–540.
- 2 S. H. Huang, P. Liu and A. Mokasdar, *Int. J. Adv. Manuf. Technol.*, 2013, **67**, 1191–1203.
- 3 A. Sasson and J. C. Johnson, *Int. J. Phys. Distrib. Logist. Manag.*, 2016, **46**, 82–94.
- 4 G. Bai, PhD thesis, Virginia Polytechnic Institute and State University, 2005.
- 5 S. B. Walker and J. A. Lewis, *J. Am. Chem. Soc.*, 2012, **134**, 1419–1421.
- 6 A. Albrecht, A. Rivadeneyra, A. Abdellah, P. Lugli and J. F. Salmerón, *J. Mater. Chem. C*, 2016, **4**, 3546–3554.
- 7 M. A. Skylar-Scott, S. Gunasekaran and J. A. Lewis, *Proc. Natl. Acad. Sci. U. S. A.*, 2016, **113**, 6137–6142.
- 8 P. Ho and H. Huntington, *J. Phys. Chem. Solids*, 1966, **27**, 1319–1329.
- 9 J. R. Black, *IEEE Trans. Electron Devices*, 1969, **16**, 338–347.
- 10 D. A. Roberson, R. B. Wicker and E. Macdonald, *J. Electron. Mater.*, 2012, **41**, 2553–2566.
- 11 G. M. Fritz and S. C. Barron, *Reactively Assisted Ink for Printed Electronic Circuits*, 2019.
- 12 J. S. Nuechterlein and J. J. Iten, *Reactive Additive Manufacturing*, 2016.
- 13 A. Merzhanov and I. Borovinskaya, *Dokl. Chem.*, 1972, **204**, 366–369.
- 14 G. M. Fritz, S. J. Spey, M. D. Grapes and T. P. Weihs, *J. Appl. Phys.*, 2013, **113**, 014901.
- 15 B. Mason, L. Groven and S. F. Son, *J. Appl. Phys.*, 2013, **114**, 113501.
- 16 A. H. Kinsey, K. Slusarski, E. Krumheuer and T. P. Weihs, *J. Mater. Sci.*, 2017, **52**, 11077–11090.
- 17 A. S. Rogachev, N. F. Shkodich, S. G. Vadchenko, F. Baras, D. Y. Kovalev, S. Rouvimov, A. A. Nepapushev and A. S. Mukasyan, *J. Alloys Compd.*, 2013, **577**, 600–605.
- 18 A. S. Mukasyan and A. S. Rogachev, *J. Mater. Sci.*, 2017, **52**, 11826–11833.
- 19 S. Q. Arlington, S. C. Barron, J. B. Delisio, J. C. Rodriguez, S. Vummidi Lakshman, J. W. Boley, J. A. Lewis, G. M. Fritz and T. P. Weihs, 2020, in preparation.
- 20 W. M. Hayt, J. E. Kemmerly and S. M. Durbin, *Engineering Circuit Analysis*, McGraw-Hill, New York, 7th edn, 2007.
- 21 D. Adams, T. L. Alford and J. W. Mayer, *Silver Metallization: Stability and Reliability*, Springer, London, 2008, pp. 75–81.
- 22 H. J. Geier, PhD thesis, University of Florida, 1974.
- 23 J. Howard, J. White and P. Ho, *J. Appl. Phys.*, 1978, **49**, 4083–4093.
- 24 R. N. Lumley, T. B. Sercombe and G. M. Schaffer, *Metall. Mater. Trans. A*, 1999, **30**, 457–463.
- 25 S. Mohan, A. Ermoline and E. L. Dreizin, *J. Nanopart. Res.*, 2012, **14**, 723.
- 26 S. Fischer and M. Grubelich, Theoretical energy release of thermites, intermetallics, and combustible metals, Sandia national laboratories technical report, 1998.
- 27 F. W. Clinard and C. P. Kemper, *J. Less-Common Met.*, 1968, **15**, 59–73.



- 28 S. J. Grisaffe, *J. Am. Ceram. Soc.*, 1960, **43**, 494.
- 29 R. O. Elliott and C. P. Kempter, *J. Phys. Chem.*, 1958, **62**, 3–4.
- 30 M. W. Barsoum, *MAX Phases: Properties of Machinable Ternary Carbides and Nitrides*, Wiley-VCH Verlag GmbH & Co. KGaA, 2013.
- 31 J. R. Cooper and R. L. Hansler, *J. Chem. Phys.*, 1963, **39**, 248–249.
- 32 *The Chemistry of Transition Metal Carbides and Nitrides*, ed. S. Oyama, Chapman & Hall, 1996, p. 10.
- 33 L. Shacklette and W. S. Williams, *Phys. Rev. B: Solid State*, 1973, **7**, 5041–5053.
- 34 E. K. Storms and C. P. Kempter, *J. Chem. Phys.*, 1965, **42**, 2043.
- 35 F. Modine, T. Haywood and C. Allison, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 1985, **32**, 7743–7747.
- 36 A. Bouhemadou, R. Khenata and M. Chegaar, *Eur. Phys. J. B*, 2007, **215**, 209–215.
- 37 S. P. Murarka, *J. Vac. Sci. Technol.*, 1980, **17**, 775–792.
- 38 A. Hendaoui, M. Andasmas, A. Amara, A. Benaldjia, P. Langlois and D. Vrel, *Int. J. Self-Propag. High-Temp. Synth.*, 2008, **17**, 129–135.
- 39 S. P. Murarka, M. H. Read, C. J. Doherty and D. B. Fraser, *J. Electrochem. Soc.*, 1982, **129**, 293–301.
- 40 J. Dunlop, G. Gruner and A. Caplin, *J. Phys. F: Met. Phys.*, 1974, **4**, 2203–2217.
- 41 M. W. Barsoum, *Prog. Solid State Chem.*, 2000, **28**, 201–281.
- 42 B. M. Radovic and M. W. Barsoum, *Am. Ceram. Soc. Bull.*, 2013, **92**, 20–27.
- 43 G. M. Fritz, H. Jores and T. P. Weihs, *Combust. Flame*, 2011, **158**, 1084–1088.
- 44 G. M. Fritz, J. A. Grzyb, O. M. Knio, M. D. Grapes and T. P. Weihs, *J. Appl. Phys.*, 2015, **118**, 135101.
- 45 M. D. Grapes and T. P. Weihs, *Combust. Flame*, 2016, **172**, 105–115.
- 46 J. H. Henninger, Solar Absorptance and Thermal Emittance of Some Common Spacecraft Thermal Control Coatings, Nasa technical report, 1984.
- 47 E. C. Clausen, W. R. Penney, D. C. Marrs, M. V. Park, A. M. Scalia and N. S. Weston, Proceedings of the 2005 ASEE Gulf-Southwest Annual Conference, 2005.
- 48 M. Schoenitz, X. Zhu and E. L. Dreizin, *Scr. Mater.*, 2005, **53**, 1095–1099.
- 49 A. S. Rogachev, S. G. Vadchenko, F. Baras, O. Politano and S. Rouvimov, *Acta Mater.*, 2014, **66**, 86–96.
- 50 S. Sen, M. Lake, R. Grieseler and P. Schaaf, *Surf. Coat. Technol.*, 2017, **327**, 25–31.
- 51 M. S. Song, B. Huang, M. X. Zhang and J. G. Li, *Powder Technol.*, 2009, **191**, 34–38.
- 52 M. S. Song, M. W. Ran and Y. Y. Kong, *Int. J. Refract. Met. Hard Mater.*, 2011, **29**, 392–396.
- 53 Q. Hu, M. Zhang, P. Luo, M. Song and J. Li, *Int. J. Refract. Met. Hard Mater.*, 2012, **35**, 251–256.
- 54 S. Q. Arlington, F. Yi, D. A. Lavan and T. P. Weihs, *AIP Adv.*, 2019, **9**, 035324.
- 55 E. A. Olson, M. Y. Efremov, M. Zhang, Z. Zhang and L. H. Allen, *J. Microelectromech. Syst.*, 2003, **12**, 355–364.
- 56 K. Xiao, J. M. Gregoire, P. J. McCluskey, D. Dale and J. J. Vlassak, *J. Appl. Phys.*, 2013, **113**, 243501.
- 57 T. Neuhauser, G. Tinti, H. Leiste, N. Casati, M. Stüber and K. Woll, *Acta Mater.*, 2020, **195**, 579–587.
- 58 J. Zapata, A. Nicollet, B. Julien, G. Lahiner, A. Esteve and C. Rossi, *Combust. Flame*, 2019, **205**, 389–396.
- 59 A. H. Kinsey, K. Slusarski, S. Sosa and T. P. Weihs, *ACS Appl. Mater. Interfaces*, 2017, **9**, 22026–22036.

